## Application/Control No. O9/522,950 Examiner Nhon T Diep Applicant(s)/Patent Under Reexamination KIKUCHI ET AL. Art Unit Page 1 of 1

## Nhon T Diep

Notice of References Cited

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,990,955	11-1999	Koz, Mark	375/240.01
	В	US-6,229,951	05-2001	Schultz et al.	386/68
	С	US-6,542,518	04-2003	Miyazawa, Satoshi	370/468
	D	US-6,404,817	06-2002	Saha et al.	375/240.27
	Ε	US-5,995,707	11-1999	Lee, Je-Hyoung	386/81
	F	US-			
	G	US-			
	н	US-			
	I	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

**U.S. PATENT DOCUMENTS** 

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				· ·	
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.